



Dual Precision JFET Input Op Amp

DESCRIPTION

Linear Technology's LF412A/AM/883 and OP-215/883 series of dual JFET input op amps feature several improvements compared to similar types from other manufacturers.

Both devices have lower input bias and offset currents over the entire temperature range, and are available in all standard 8-pin packages.

In addition, Linear's LF412A/883 has lower voltage noise and higher voltage gain. Linear's OP-215 supply currents are nearly halved.

These devices are processed to the requirements of MIL-STD-883 Class B to yield circuits usable in precision military applications.

ABSOLUTE MAXIMUM RATINGS

Supply Voltage

LF412AM, OP-215A ±22V

LF412M, OP-215C ±18V

Internal Power Dissipation 670mW

Differential Input Voltage

LF412AM, OP-215A ±40V

LF412M, OP-215C ±30V

Input Voltage (Note C)

LF412AM, OP-215A ±20V

LF412M, OP-215C ±16V

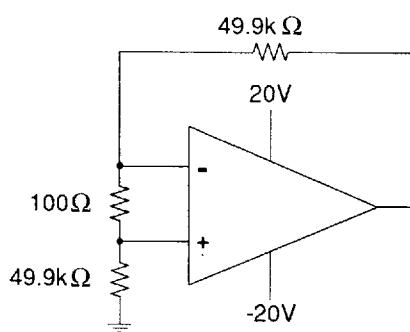
Output Short Circuit Duration Indefinite

Operating Temperature Range -55°C to 125°C

Storage Temperature Range -65°C to 150°C

Lead Temperature (Soldering, 10 sec.) 300°C

BURN-IN CIRCUIT



PACKAGE/ORDER INFORMATION

| ORDER PART NO. |
|---|
| LF412AMH/883 LF412MH/883 OP-215AH/883 OP-215CH/883 |
| PART MARKING† |
| LF412AMH/883C LF412MH/883C OP-215AH/883C OP-215CH/883C |
| ORDER PART NO. |
| LF412AMJ8/883 LF412MJ8/883 OP-215AJ8/883 OP-215CJ8/883 |
| PART MARKING† |
| LF412AMJ8/883C LF412MJ8/883C OP-215AJ8/883C OP-215CJ8/883C |

† The suffix letter "C" of the part mark indicates compliance per MIL-STD-883, para 1.7.1.1.



TABLE 1: ELECTRICAL CHARACTERISTICS **$V_S = \pm 15V$, $V_{CM} = 0V$, $T_A = 25^\circ C$ unless otherwise noted.**

| SYM-BOL | PARAMETER | CONDITIONS | NOTES | OP-215A | | | LF412AM | | | LF412M, OP-215C | | | SUB-GROUP | UNITS |
|-----------|------------------------------|--|--------|----------------------|------------------------|-----|----------------------|------------------------|-----|----------------------|------------------------|--------|----------------------------------|-------|
| | | | | MIN | Typ | MAX | MIN | Typ | MAX | MIN | Typ | MAX | | |
| V_{OS} | Input Offset Voltage | | | 0.2 | 1.0 | | 0.3 | 1.0 | | 0.5 | 3.0 | 1 | mV | |
| I_{OS} | Input Offset Current | $T_J = 25^\circ C$ Warmed-Up | A A | 6 10 | 50 100 | | 6 10 | 50 100 | | 10 15 | 100 200 | 1 1 | pA pA | |
| I_B | Input Bias Current | $T_J = 25^\circ C$ Warmed-Up | A A | ± 10 ± 15 | ± 100 ± 300 | | ± 10 ± 15 | ± 100 ± 300 | | ± 15 ± 20 | ± 200 ± 400 | 1 1 | pA pA | |
| R_{IN} | Input Resistance | | | 10^{12} | | | 10^{12} | | | 10^{12} | | | Ω | |
| AV_{OL} | Large Signal Voltage Gain | $R_L \geq 2k\Omega$, $V_O = \pm 10V$ | | 150 | 400 | | 100 | 300 | | 50 | 250 | 4 | V/mV | |
| V_O | Output Voltage Swing | $R_L = 10k\Omega$ $R_L = 2k\Omega$ | | ± 12 ± 11 | ± 13 ± 12.7 | | ± 12 ± 11 | ± 13 ± 12.7 | | ± 12 ± 11 | ± 13 ± 12.7 | 4 4 | V V | |
| I_S | Supply Current | | | 3.8 | | | 3.8 | | | 3.8 | | | mA | |
| SR | Slew Rate | | | 10 | 15 | | 10 | 15 | | 8 | 13 | 7 | V/ μ s | |
| GBW | Gain Bandwidth Product | | B | 3.5 | 5.7 | | 3.5 | 5.7 | | 3.0 | 5.5 | | MHz | |
| | Settling Time | to 0.01% to 0.10% | | 2.3 1.1 | | | 2.3 1.1 | | | 2.4 1.2 | | | μ s μ s | |
| | Input Voltage Range | | B B | ± 11 -11.5 | $+14.5$ -11.5 | | ± 11 | $+19.5$ -16.5 | | ± 11 | $+14.5$ -11.5 | | V V | |
| CMRR | Common-Mode Rejection Ratio | $V_{CM} = \pm 16V$ $V_{CM} = \pm 11V$ $V_{CM} = \pm 10.5V$ | | 78 86 | 100 100 | | 80 | 100 | | 72 82 | 100 100 | 1 1 | dB dB | |
| PSRR | Power Supply Rejection Ratio | $V_S = \pm 10V$ to $\pm 20V$ $V_S = \pm 10V$ to $\pm 18V$ | | 86 | 100 | | 80 | 100 | | 80 | 100 | 1 1 | dB dB | |
| e_n | Input Noise Voltage Density | $f_o = 100Hz$ $f_o = 1000Hz$ | | 20 15 | | | 20 15 | | | 20 15 | | | nV/\sqrt{Hz} nV/\sqrt{Hz} | |
| i_n | Input Noise Current Density | $f_o = 100Hz$ $f_o = 1000Hz$ | | 0.01 0.01 | | | 0.01 0.01 | | | 0.01 0.01 | | | pA/\sqrt{Hz} pA/\sqrt{Hz} | |
| | Channel Separation | $f = 1Hz$ to $20kHz$ | | 120 | | | 120 | | | 120 | | | dB | |

 $V_S = \pm 15V$, $V_{CM} = 0V$, $-55^\circ \leq T_A \leq 125^\circ C$ unless otherwise noted.

| SYM-BOL | PARAMETER | CONDITIONS | NOTES | OP-215A | | | LF412AM | | | LF412M, OP-215C | | | SUB-GROUP | UNITS |
|------------------|------------------------------------|--|--------|------------------------|----------------------|-----|------------------------|----------------------|-----|------------------------|----------------------|------------|-----------|-------------------|
| | | | | MIN | Typ | MAX | MIN | Typ | MAX | MIN | Typ | MAX | | |
| V_{OS} | Input Offset Voltage | | | 0.5 | | | 0.7 | | | 1.0 | | | 2.3 | mV |
| | Average Input Offset Voltage Drift | | B | 3 | | | 4 | | | 5 | | | 2.3 | $\mu V/^{\circ}C$ |
| I_{OS} | Input Offset Current | $T_J = 125^\circ C$ $T_A = 125^\circ C$, Warmed-Up | A B | 0.8 1.2 | 8 14 | | 0.8 1.2 | 8 14 | | 1.0 1.5 | 12 22 | 2 2 | nA nA | |
| I_B | Input Bias Current | $T_J = 125^\circ C$ $T_A = 125^\circ C$, Warmed-Up | A B | ± 1.5 ± 2.2 | ± 10 ± 18 | | ± 1.5 ± 2.2 | ± 10 ± 18 | | ± 1.8 ± 2.7 | ± 15 ± 28 | 2 2 | nA nA | |
| | Input Voltage Range | OP-215 | B | ± 10.3 | $+14.5$ -11.5 | | | | | ± 10.3 | $+14.5$ -11.5 | | V V | |
| | | LF412 | B | | | | ± 16 | $+19.5$ -16.5 | | ± 11 | $+14.5$ -11.5 | | V V | |
| CMRR | Common-Mode Rejection Ratio | $V_{CM} = \pm 16V$ $V_{CM} = \pm 11V$ $V_{CM} = \pm 10.3V$ | | 82 | 100 | | 80 | 100 | | 70 80 | 100 100 | 2.3 2.3 | dB dB | |
| I_S | Supply Current | | | 4.2 | | | 4.0 | | | 4.2 | | | 2.3 | mA |
| PSRR | Power Supply Rejection Ratio | $V_S = \pm 10V$ to $\pm 20V$ $V_S = \pm 10V$ to $\pm 16V$ | | 80 | 100 | | 80 | 100 | | 78 | 100 | 2.3 2.3 | dB dB | |
| AV _{OL} | Large Signal Voltage Gain | $R_L \geq 2k\Omega$, $V_O = \pm 10V$ $V_S = \pm 15V$ | | 30 | 150 | | 30 | 150 | | 25 | 150 | 5.6 | V/mV | |
| V_O | Output Voltage Swing | $R_L \geq 10k\Omega$ | | ± 12 | | | ± 12 | | | ± 12 | | | 5.6 | V |

Note A: Input bias and offset currents are specified for two different conditions. The T_J specification is with the junction at ambient temperature; the warmed-up specification is with the device operating in a warmed-up condition at the ambient temperature specified.

Note B: This parameter is guaranteed by design, characterization, or correlation to other tests.

Note C: Maximum negative input voltage is equal to the negative supply voltage.

TABLE 2: ELECTRICAL TEST REQUIREMENTS

| MIL-STD-883 TEST REQUIREMENTS | SUBGROUP |
|---|----------------|
| Final Electrical Test Requirements (Method 5004) | 1*,2,3,4,5,6,7 |
| Group A Test Requirements (Method 5005) | 1,2,3,4,5,6,7 |
| Group C and D End Point Electrical Parameters (Method 5005) | 1 |

PDA Test Notes

The PDA is specified as 5% based on failures from group A, subgroup 1, tests after cooldown as the final electrical test in accordance with method 5004 of MIL-STD-883 Class B. The verified failures of group A, subgroup 1, after burn-in divided by the total number of devices submitted for burn-in in that lot shall be used to determine the percent defective for the lot.

* PDA applies to subgroup 1. See PDA test notes.

Linear Technology Corporation reserves the right to test to tighter limits than those given.